# imall

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ALPHA & OMEGA SEMICONDUCTOR		<b>AON1611</b> 20V P-Channel MOSFET				
General Description		Product Summary				
The AON1611 combines advanced trench M technology with a low resistance package to extremely low $R_{DS(ON)}$ . This device is ideal for and battery protection applications.		-20V -4A < 58mΩ < 76mΩ < 98mΩ < 120mΩ				
	Typical ESD protection		HBM Class 2			
DFN 1.6x1.6A Top View Bottom	Pir					
Absolute Maximum Ratings T <sub>A</sub> =25C unless Parameter	Symbol		mum	Units		
Drain-Source Voltage	V <sub>DS</sub>	-20		V		
Gate-Source Voltage	V <sub>GS</sub>	±8		V		
Continuous Drain $T_A=25^{\circ}$ Current G $T_A=70^{\circ}$	I <sub>D</sub>	-4 -3		A		
Pulsed Drain Current <sup>ċ</sup>	I <sub>DM</sub>	-16				
Power Dissipation <sup>A</sup> $T_A=25$ C $T_A=70$ C	— P <sub>D</sub>	1.8		- w		
Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>STG</sub>	-55 to 150		C		
				·		
Thermal Characteristics		· - ·				
Parameter	Symbol	Тур	Max	Units		
Maximum Junction-to-Ambient <sup>A</sup> t ≤ 10s Maximum Junction-to-Ambient <sup>A D</sup> Steady-Stat	R <sub>0JA</sub>	56	70	°C/W		
Maximum Junction-to-Ambient AD Steady-State		88 110		°C/W		



#### Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units
STATIC	PARAMETERS						
$BV_{DSS}$	Drain-Source Breakdown Voltage	$I_{D}$ =-250 $\mu$ A, $V_{GS}$ =0V		-20			V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS}$ =-20V, $V_{GS}$ =0V				-1	μA
		Т	Ր <sub>J</sub> =55℃			-5	μΛ
I <sub>GSS</sub>	Gate-Body leakage current	$V_{DS}=0V, V_{GS}=\pm 8V$				±10	μA
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_{D}=-250\mu A$		-0.3	-0.6	-0.9	V
I <sub>D(ON)</sub>	On state drain current	$V_{GS}$ =-10V, $V_{DS}$ =-5V		-16			Α
R <sub>ds(on)</sub>		$V_{GS}$ =-4.5V, $I_{D}$ =-4A			46	58	mΩ
	Static Drain-Source On-Resistance	T <sub>J</sub>	=125℃		64.5	80	11122
		$V_{GS}$ =-2.5V, $I_{D}$ =-3A			58	76	mΩ
		$V_{GS}$ =-1.8V, $I_{D}$ =-2A			74	98	mΩ
		$V_{GS}$ =-1.5V, $I_{D}$ =-1A			88	120	mΩ
g <sub>FS</sub>	Forward Transconductance	$V_{DS}$ =-5V, $I_{D}$ =-4A			15		S
$V_{SD}$	Diode Forward Voltage	I <sub>S</sub> =-1A,V <sub>GS</sub> =0V			-0.66	-1	V
ls	Maximum Body-Diode Continuous Current					-2.5	Α
DYNAMI	C PARAMETERS						
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> =0V, V <sub>DS</sub> =-10V, f=1MHz			550		pF
C <sub>oss</sub>	Output Capacitance				93		pF
C <sub>rss</sub>	Reverse Transfer Capacitance				64		рF
R <sub>g</sub>	Gate resistance	$V_{GS}$ =0V, $V_{DS}$ =0V, f=1MHz			12		Ω
SWITCH	ING PARAMETERS						
Q <sub>g</sub> (4.5V)	Total Gate Charge	V <sub>GS</sub> =-4.5V, V <sub>DS</sub> =-10V, I <sub>D</sub> =-4A			7	10	nC
$Q_{gs}$	Gate Source Charge				1		nC
$Q_{gd}$	Gate Drain Charge				1.8		nC
t <sub>D(on)</sub>	Turn-On DelayTime				15		ns
t <sub>r</sub>	Turn-On Rise Time	$V_{GS}$ =-4.5V, $V_{DS}$ =-10V, $R_L$ =2.5 $\Omega$ , $R_{GEN}$ =3 $\Omega$			33		ns
t <sub>D(off)</sub>	Turn-Off DelayTime				50		ns
t <sub>f</sub>	Turn-Off Fall Time				43		ns
t <sub>rr</sub>	Body Diode Reverse Recovery Time	I <sub>F</sub> =-4A, dI/dt=100A/μs			16		ns
Q <sub>rr</sub>	Body Diode Reverse Recovery Charge	I <sub>F</sub> =-4A, dl/dt=100A/μs			6.5		nC

A. The value of  $R_{6JA}$  is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A = 25^{\circ}$  C. The Power dissipation  $P_{\text{DSM}}$  is based on R  $_{\text{6JA}}$  t  $\,\leqslant\,$  10s value and the maximum allowed junction temperature of 150  $^\circ\,$  C. The value in any given application depends on the user's specific board design.

B. The power dissipation  $P_D$  is based on  $T_{J(MAX)}=150^{\circ}$  C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature T<sub>J(MAX)</sub>=150° C. Ratings are based on low frequency and duty cycles to keep initial  $T_J = 25^{\circ}$  C.

D. The  $R_{\text{6JA}}$  is the sum of the thermal impedance from junction to case  $R_{\text{6JC}}$  and case to ambient.

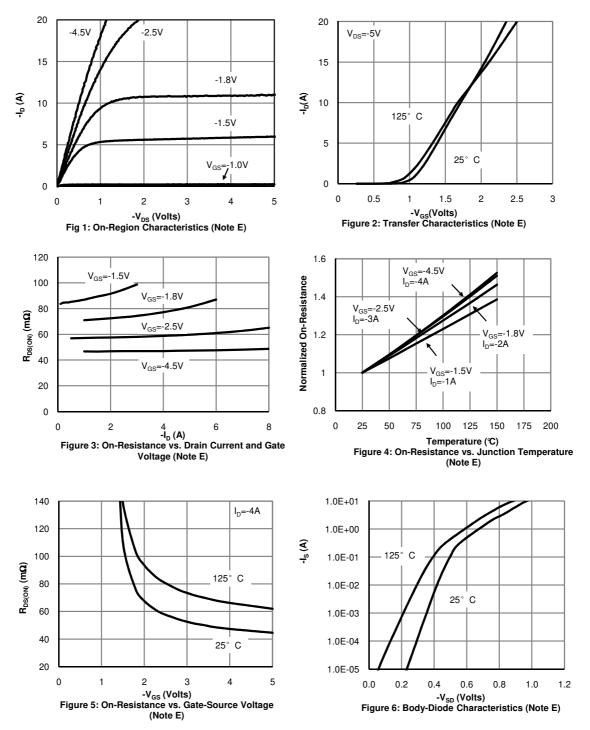
E. The static characteristics in Figures 1 to 6 are obtained using <300 µs pulses, duty cycle 0.5% max. F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of  $T_{J(MAX)}$ =150° C. The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited. H. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^{\circ}$  C.

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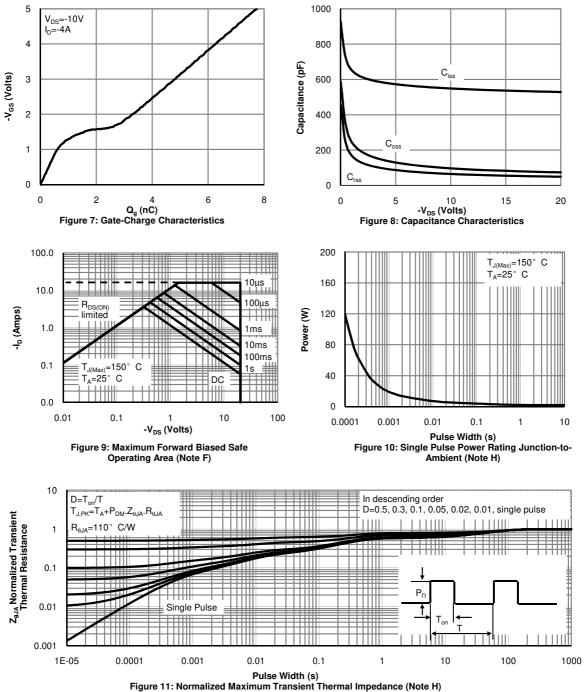
# TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS





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#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

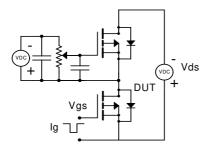


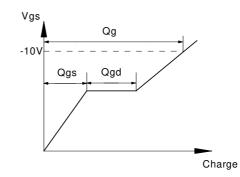


<sup>-</sup> 90%

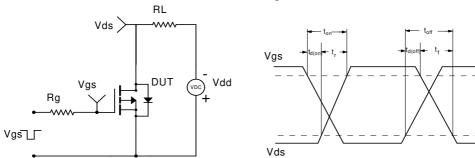
\_10%

### Gate Charge Test Circuit & Waveform

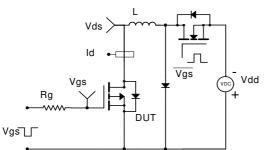


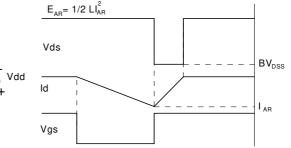


Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





# Diode Recovery Test Circuit & Waveforms

